

Notice of References Cited	Application/Control No. 10/521,242		Applicant(s)/Patent Under Reexamination OGAWA, MIKI	
	Examiner NATHAN H. EMPIE		Art Unit 1792	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,076,980	12-1991	Nogues et al.	264/621
*	B	US-2006/0057296	03-2006	Ogawa et al.	427/377
	C	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 9937705 A1	07-1999	World Intellect	STUCKY et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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